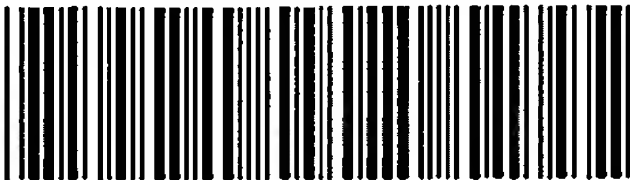


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/644,341	FORSTER ET AL.	
	Examiner	Art Unit	
	Paul Kim	2857	

SEARCHED			
Class	Subclass	Date	Examiner
702	45,50 182	6/11/2005	PK
73	861.02	6/11/2005	PK
	861.03	6/11/2005	PK
	861.42	6/11/2005	PK
	861.43	6/11/2005	PK
	1.16	6/11/2005	PK
702	100	6/11/2005	PK

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	6/11/2005	PK
GOOGLE	6/11/2005	PK